<u>MOSFET</u> – Power, Single, N-Channel, SO-8 FL

30 V, 210 A

Features

- Low R_{DS(on)} to Improve Conduction and Overall Efficiency
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- OR-ing FET, Power Load Switch, Motor Control
- Refer to Application Note AND8195/D for Mounting Information **End Products**
- Server, UPS, Fault-Tolerant Power Systems, Hot Swap

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	34	Α
Current R _{0JA} (Note 1)		$T_A = 100^{\circ}C$		21.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.74	W
Continuous Drain		$T_A = 25^{\circ}C$	۱ _D	43	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 100°C		27	
$\begin{array}{l} \text{Power Dissipation} \\ R_{\theta JA} \leq 10 \text{ s (Note 1)} \end{array}$	Steady	T _A = 25°C	P _D	7.3	W
Continuous Drain	State	$T_A = 25^{\circ}C$	I _D	20	А
Current $R_{\theta JA}$ (Note 2)		T _A = 100°C		12.5	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	1.06	W
Continuous Drain		T _C = 25°C	۱ _D	210	А
Current R _{θJC} (Note 1)		T _C =100°C		132	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	104	W
Pulsed Drain Current	T _A = 25°	² C, t _p = 10 μs	I _{DM}	400	А
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to +150	°C
Source Current (Body Diode)		۱ _S	95	А	
Drain to Source DV/DT		dV/d _t	4.4	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 24 V, V _{GS} = 10 V, I _L = 58 A _{pk} , L = 0.3 mH, R _G = 25 Ω)		E _{AS}	504	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

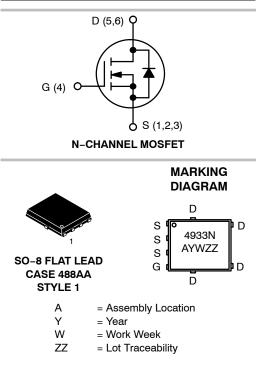
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	1.2 m Ω @ 10 V	210 A
30 V	2.0 mΩ @ 4.5 V	210 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4933NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4933NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

2. Surface–mounted on FR4 board using the minimum recommended pad size. (Cu area = 50 mm² [1 oz])

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.1	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	45.6	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	117.5	°C/W
Junction-to-Ambient – (t \leq 10 s) (Note 3)	$R_{ hetaJA}$	17.13	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size. (Cu area = 50 mm² [1 oz])

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		V _{DS} = 24 V	T _J = 125°C			10	- μΑ
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		0.9	1.2	
			I _D = 15 A		0.9		
		V _{GS} = 4.5 V	I _D = 30 A		1.5	2.0	mΩ
			I _D = 15 A		1.5		
Forward Transconductance	9 FS	V _{DS} = 1.5 V, I _D) = 15 A		82		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}				10930		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			3230		pF
Reverse Transfer Capacitance	C _{RSS}				92		
Total Gate Charge	Q _{G(TOT)}				62.1		
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 4.5 V, V_{DS} = 15 V; I _D = 30 A			15.7		nC
Gate-to-Source Charge	Q _{GS}				27		
Gate-to-Drain Charge	Q _{GD}				10.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	5 V; I _D = 30 A		148		nC
SWITCHING CHARACTERISTICS (Note 6)							
Turn–On Delay Time	t _{d(ON)}				31		
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,			33		1

Turn-Off Delay Time

Fall Time

5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

t_{d(OFF)}

t_f

 V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω

ns

47

23

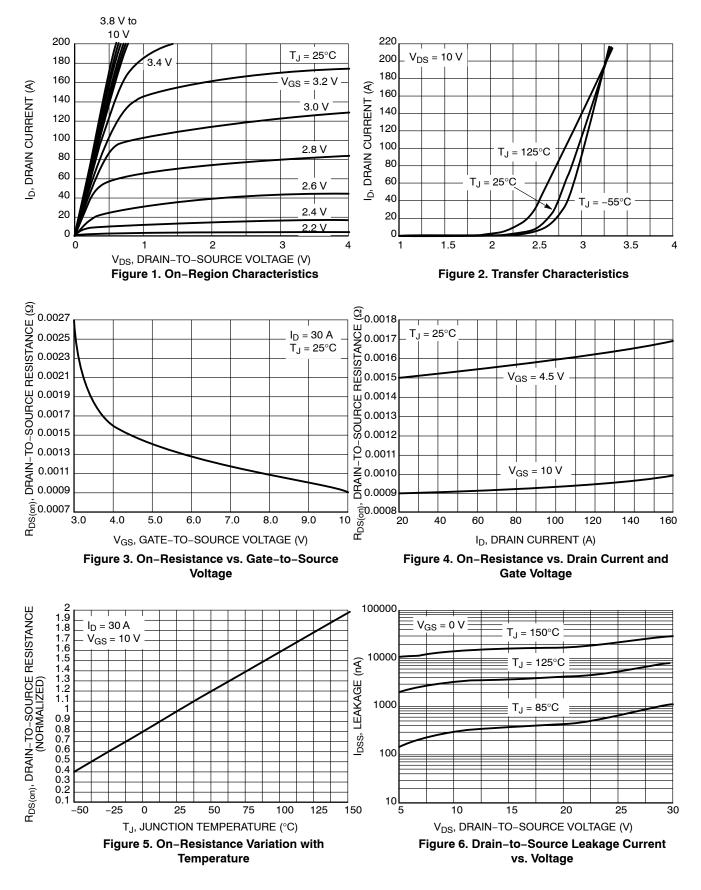
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)			•	•	•	
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			20		- ns
Rise Time	t _r				26		
Turn-Off Delay Time	t _{d(OFF)}				88.6		
Fall Time	t _f				22		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 30 A	$T_J = 25^{\circ}C$		0.82	1.1	v
			T _J = 125°C		0.68		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			73.5		ns
Charge Time	t _a				35.9		
Discharge Time	t _b				37.6		
Reverse Recovery Charge	Q _{RR}				117		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			0.50		nH
Drain Inductance	L _D				0.005		nH
Gate Inductance	L _G				1.84		nH
Gate Resistance	R _G				1.1	2.2	Ω

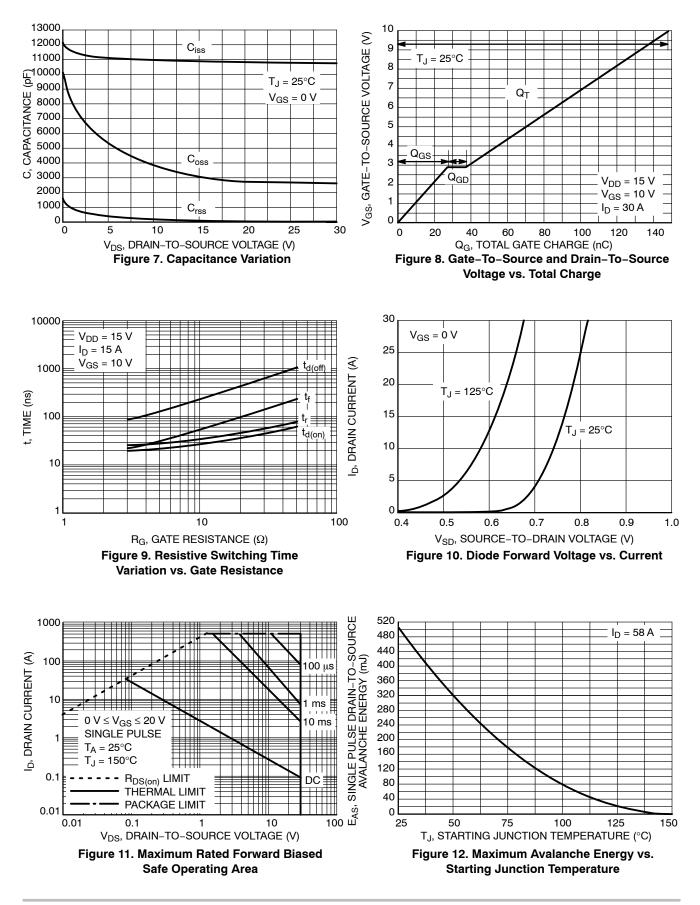
5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

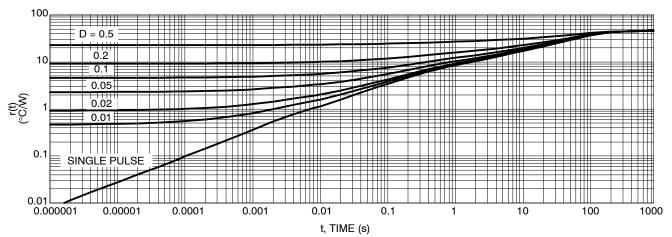
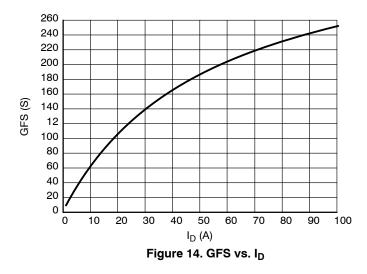
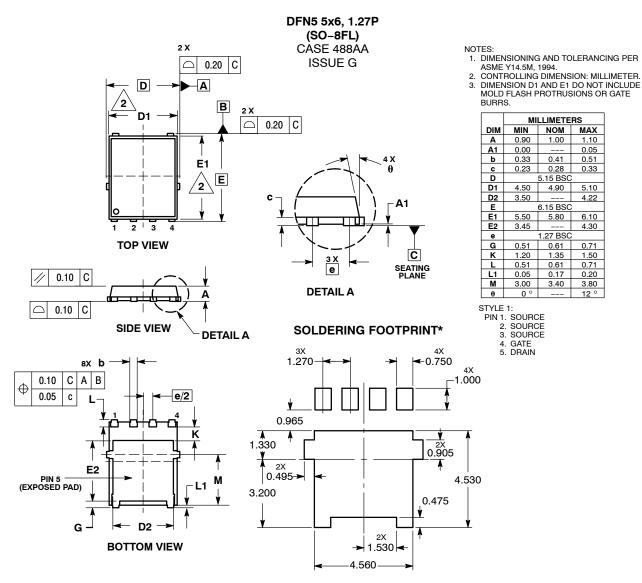


Figure 13. Thermal Response



PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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